


<b>Search Notes</b> 	<b>Application/Control No.</b> 10567549	<b>Applicant(s)/Patent Under Reexamination</b> SHINKAI ET AL.
	<b>Examiner</b> DAQUAN ZHAO	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner
386	52, 55, 95, 108	5/12/2009	dz

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT; USPGPUB; USOCR; EPO; DERENT; JPO; IBM_TDB	5/12/2009	DZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--